

**Search Notes**

Application/Control No.

10/790,752

Examiner

David J. Makiya

Applicant(s)/Patent under  
Reexamination

ZIRK ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	109	11/23/2005	DJM
	119-120		
7	118-120	11/22/2005	DJM
	145,159		
	168		
30	308.1	11/22/2005	DJM
	308.2		
	153		
7	114-116	11/29/2005	DJM
	122,170		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
362	119,120	11/29/2005	DJM
7	118,145	11/29/2005	DJM
7	159	11/29/2005	DJM
30	308.1,308.2	11/29/2005	DJM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search in EAST attached	11/23/2005	DJM
Consulted with Debra Meislin regarding allowable subject matter	11/29/2005	DJM